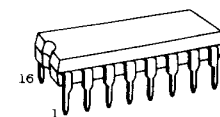


TC40H138P/F

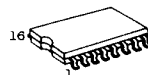
C²MOS DIGITAL INTEGRATED CIRCUIT
SILICON MONOLITHIC**TC40H138 3-TO-8-LINE DECODER/DEMULTIPLEXER**

The TC40H138 is a DECODER/DEMULTIPLEXER which can select arbitrary one of eight output lines through three binary input lines A, B and C. In this case, the selected output goes to "L" level.

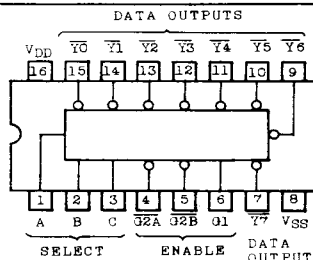
Further, when ENABLE input G1 is set to "L" level or ENABLE input $\overline{G2}$ to "H" level, selection is inhibited regardless of other input signals, and all the outputs go to "H" level.



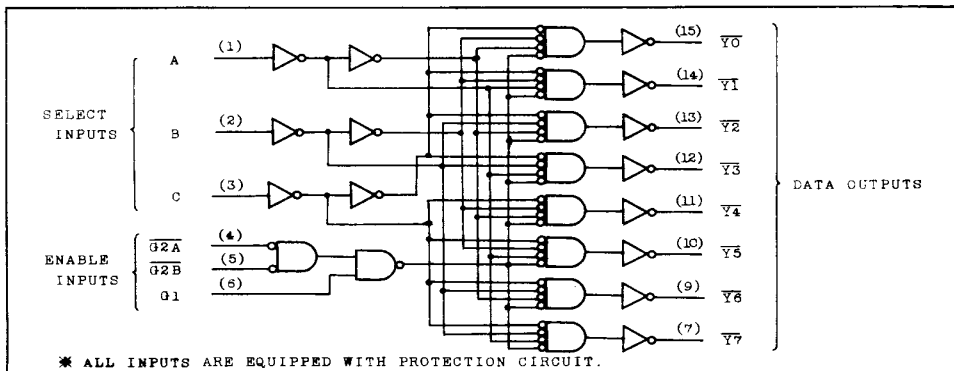
DIP16(3D16A-P)



MFP16(F16GC-P)

PIN CONNECTION**MAXIMUM RATINGS**

CHARACTERISTIC	SYMBOL	RATING	UNIT
Supply Voltage	V _{DD}	V _{SS} -0.5 ~ V _{SS} +10	V
Input Voltage	V _{IN}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Output Voltage	V _{OUT}	V _{SS} -0.5 ~ V _{DD} +0.5	V
Input Current	I _{IN}	±10	mA
Power Dissipation	P _D	300(DIP)/180(MFP)	mW
Storage Temperature	T _{stg}	-65 ~ 150	°C
Lead Temp./Time	T _{sol}	260° • 10 sec	

LOGIC DIAGRAM**TOSHIBA**

CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Voltage	V _{DD}	-	2.0	-	8.0	V
Input Voltage	V _{IN}	-	0	-	V _{DD}	V
Operating Temperature	T _{opr}	-	-40	-	85	°C

[illegible]

CHARACTERISTIC		SYMBOL	TEST CONDITION	V _{DD} (V)	-40°C		25°C			85°C		UNIT
					MIN.	MAX.	MIN.	TYP.	MAX.	MIN.	MAX.	
High Level Output Voltage		V _{OH}	$I_{OUT} < 1\mu A$ $V_{IN} = V_{SS}, V_{DD}$	5	4.95	-	4.95	5.0	-	4.95	-	V
Low Level Output Voltage		V _{OL}	$I_{OUT} < 1\mu A$ $V_{IN} = V_{SS}, V_{DD}$	5	-	0.05	-	0.0	0.05	-	0.05	
High Level Output Current		I _{OH}	V _{OH} =4.6V $V_{IN} = V_{SS}, V_{DD}$	5	-0.52	-	-0.44	-	-	-0.36	-	mA
Low Level Output Current		I _{OL}	V _{OL} =0.4V $V_{IN} = V_{SS}, V_{DD}$	5	1.4	-	1.1	-	-	0.8	-	
Input Voltage	"H" Level	V _{IH}	$I_{OUT} < 1\mu A$	5	4.0	-	4.0	-	-	4.0	-	V
	"L" Level	V _{IL}	V _{OUT} =0.5V V _{OUT} =4.5V	5	-	1.0	-	-	1.0	-	1.0	
Input Current	"H" Level	I _{IH}	V _{IH} =8.0V	8	-	0.3	-	10 ⁻⁵	0.3	-	1.0	μA
	"L" Level	I _{IL}	V _{IL} =0.0V	8	-	-0.3	-	-10 ⁻⁵	-0.3	-	-1.0	
Quiescent Supply Current		I _{DD}	*V _{IN} =V _{SS} , V _{DD}	5	-	12.5	-	10 ⁻²	12.5	-	75	μA

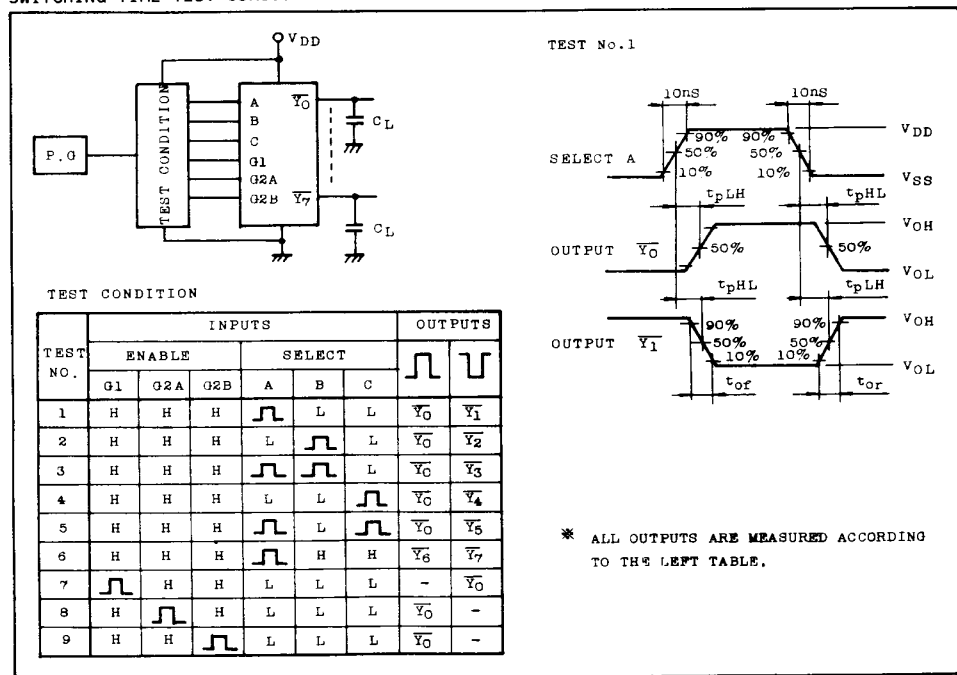
TOSHIBA

TC40H138P/F

SWITCHING CHARACTERISTIC (Ta=25°C, VSS=0.0V, CL=15pF)

CHARACTERISTIC	SYMBOL	TEST CONDITION	VDD (V)	MIN.	TYP.	MAX.	UNIT
Output Rise Time	t _{or}		5	-	17	35	ns
Output Fall Time	t _{of}		5		13	30	
Propagation Delay Time (Low-High)	t _{pLH}	SELECT- \bar{Y}	5		35	53	ns
Propagation Delay Time (High-Low)	t _{pHL}		5		40	60	
Propagation Delay Time (Low-High)	t _{pLH}	ENABLE- \bar{Y}	5	-	35	53	ns
Propagation Delay Time (High-Low)	t _{pHL}		5	-	40	60	
Input Capacitance	C _{IN}			-	5	-	pF

SWITCHING TIME TEST CIRCUIT AND WAVEFORM



TC40H138P/F

